Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/755.635	ZADEREJ ET AL.
Examiner	Art Unit
Hae M. Hveon	2839

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
439	74	4/05	honh
439	931	V	V

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Update Search Done	4/05	hmh	
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